
Current State of **High-Precision EM Side-Channel Attacks** and Implications on FPGA-Based Systems

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About Side-Channel Precision ...

Very Low-Precision Electromagnetic Field Measurements



Figure: De Mulder et al., 2007

Low-Precision Electromagnetic Field Measurements

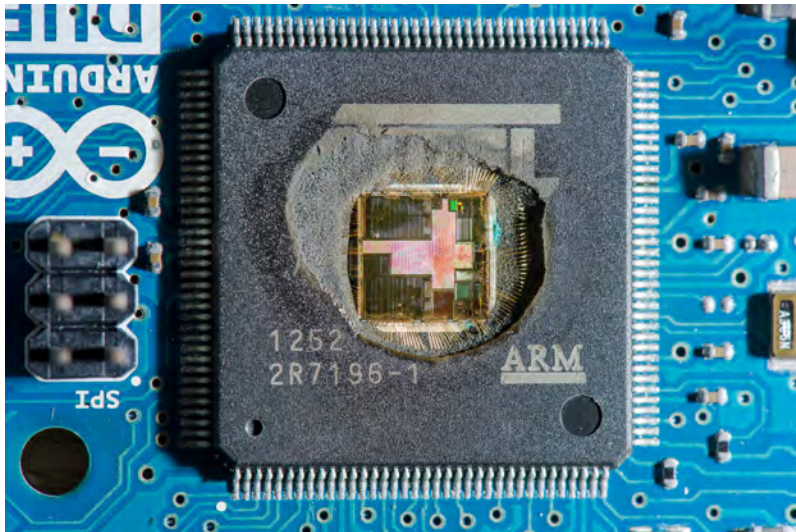


- Recover Linux filesystem encryption key (AES) on a BeagleBone (500 MHz ARM Cortex)
- Coil diameters of 0.5 mm - 2.5 mm, bandwidth: $\approx 250\text{MHz}$

Higher Precision Requires Invasion - Decapsulation



Higher Precision Requires Invasion - Decapsulation



High-Precision EM Side-Channel Analysis

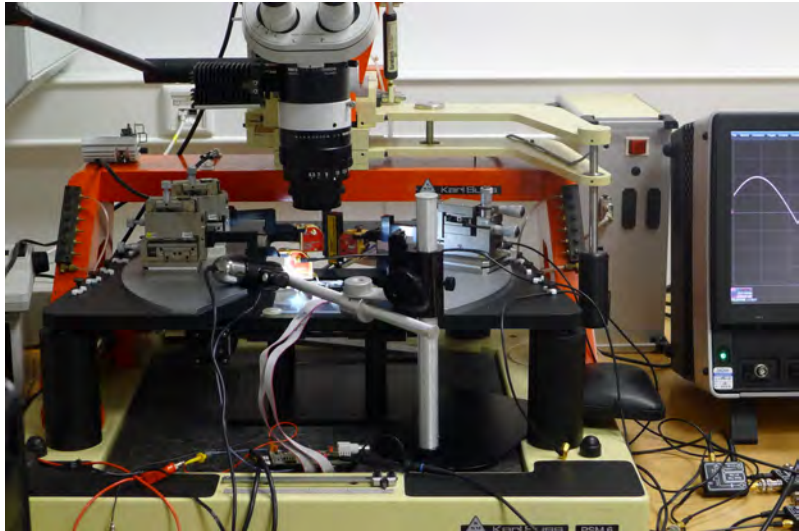


Measurement Setup for High-Precision EM SCA



- Best-case measurement setup for worst-case high-security evaluation
- Coil diameter: 0.1 mm - 0.25 mm, bandwidth: 3 GHz

Measurement Setup for High-Precision EM SCA



Measurement Setup for High-Precision EM SCA

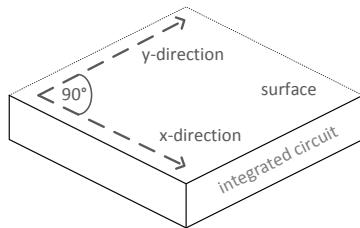
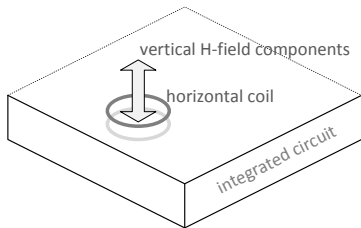
Setup Details



- High resolution in location and time
 - Circuit parts instead of entire circuit (but no single gates / FFs!)
 - Less parasitics (low-pass filtering) for higher time-resolution
 - But: Smaller coils means less magnetic flux, more amplification, more noise
- Coil diameter: $100\mu m$ – $250\mu m$, bandwidth: 3 GHz
- Amplification: 2 x 30 dB
- Oscilloscope: 1.5 GS/s minimum, 5 GS/s mostly; 2.5 GHz bandwidth; (8 bit resolution)
- (No EM shielding box)

Measurement Setup for High-Precision EM SCA

Setup Details



- Horizontal coil orientation
- Front-side measurement (because backside substrate leads to low signal e.g. -19 dB)
- Move coil over decapsulated die surface in x-y-grid
- Distance to surface: $\approx 10 - 30\mu m$ (touch down and lift slightly)
- Positioning of coil: $\approx 0.5\mu m$ resolution
- Time / memory depends on case: e.g. 4 days for 40×40 grid, $70\mu m$ step size, 10k traces at 1600 positions total 33 GBytes, then e.g. 500k traces at ≈ 10 selected locations

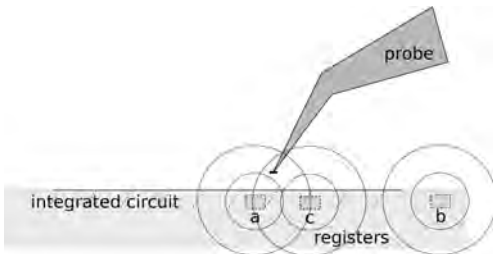
Asymmetric Cryptography

Exponentiation Algorithms

CT-RSA 2012*

- Example **pseudo**-algorithm: **Input:** Secret $d = d_D d_{D-1} \dots d_2 d_1$ with $d_i \in \{0, 1\}$

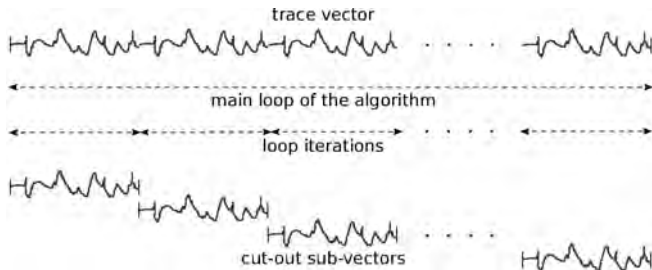
```
1: for  $i = D$  downto 1 do
2:   if  $d_i = 1$  then
3:      $c \leftarrow c^2 + a$ 
4:      $a \leftarrow c$ 
5:   else
6:      $c \leftarrow c^2 + b$ 
7:      $b \leftarrow c$ 
8:   end if
9: end for
```



- Usual countermeasures: Constant time (e.g. Montgomery), randomized coordinates
- Can be attacked using single traces ('horizontal attacks')
- Single execution leakage: E.g. leakage from locations
- *Heyszl, Mangard, Heinz, Stumpf, Sigl, 'Localized Electromagnetic Analysis of Cryptographic Implementations', CT-RSA 2012

Horizontal Attacks

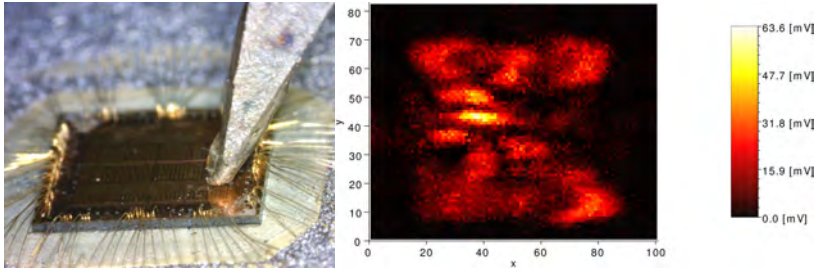
CT-RSA 2012*



- Single-trace attack, e.g. EC scalar multiplication in ECDSA
- *Heyszl, Mangard, Heinz, Stumpf, Sigl, 'Localized Electromagnetic Analysis of Cryptographic Implementations', CT-RSA 2012

Profiled Attack

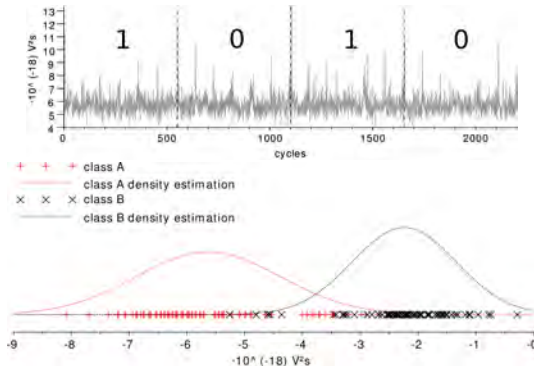
CT-RSA 2012*



- Xilinx Spartan 3A 90 nm
- Scan of surface, profiling, use best position with highest difference btw. 0 and 1
- Template attack successful - Exploiting single-execution leakage
- *Heyszl, Mangard, Heinz, Stumpf, Sigl, 'Localized Electromagnetic Analysis of Cryptographic Implementations', CT-RSA 2012

Attack w/o Profiling - Clustering-Based

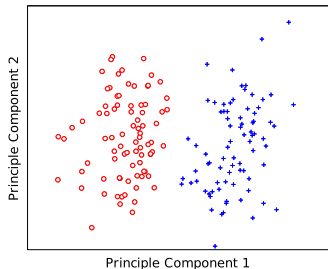
CARDIS 2013*



- No profiling → First horizontal attack based on **unsupervised** cluster classification
- Non-heuristic / state-of-art in pattern classification: e.g. k-means, Euclidean distance (contrary to hor. cross-corr. / Big Mac)
- Remaining entropy at some positions (posterior prob. for enumeration) $\approx 2^{22} - 2^{37}$
- *Heyszl, Ibing, Mangard, De Santis, Sigl, 'Clustering Algorithms for Non-profiled Single-Execution Attacks on Exponentiations', CARDIS 2013

Multiple Probes

COSADE 2015*



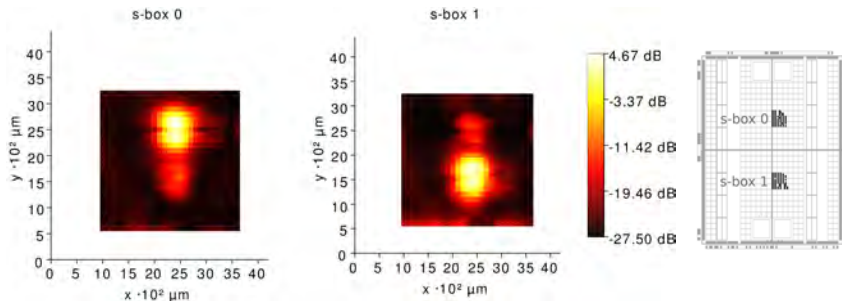
- Improved algorithms: PCA for dim. reduction, expectation-maximization alg.
- PCA: most leakage in components e.g. 5 to 7, no leakage after 20
- Remaining entropy at some positions (posterior prob. for enumeration) $\approx 2^0$
- Combining leakage of multiple probes: Better success probability from mult. locations, but quality 'better' only profiled - Helpful if single-shot attack with insufficient SNR
- *Specht, Heyszl, Kleinsteuber, Sigl, 'Improving Non-profiled Attacks on Exponentiations Based on Clustering and Extracting Leakage from Multi-channel High-Resolution EM Measurements', COSADE 2015

Symmetric Crypto



S-Box SNR

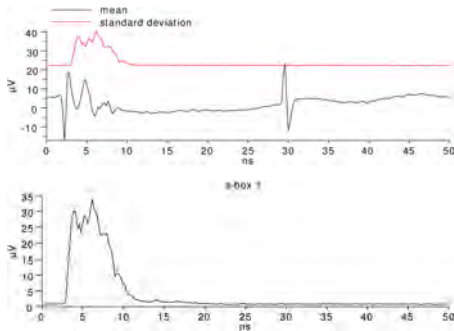
CARDIS 2012*



- Localized signal leakage: (1) Higher SNR (e.g. $\approx +4\text{dB}$), (2) two s-boxes distinctively
- 90 nm Xilinx Spartan-3A
- *Heyszl, Merli, Heinz, De Santis, Sigl, 'Strengths and limitations of high-resolution electromagnetic field measurements for side-channel analysis', CARDIS 2012
- About probe size, positioning, distance, etc. also Specht, Heyszl, Sigl, 'Investigating measurement methods for high-resolution electromagnetic field side-channel analysis', ISIC 2014

S-Box SNR

CARDIS 2012*



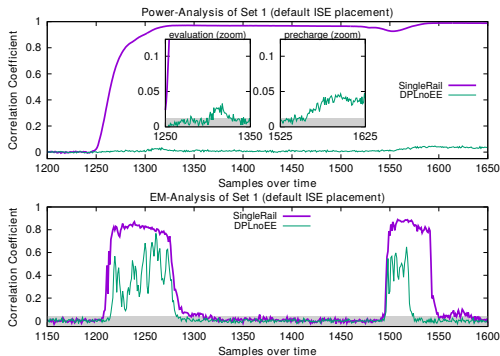
- At position over s-box 1: mean and std dev above, extracted signal of s-box 1 below
- Time-precision: Detected leakage during time as short as critical path ($\approx 10ns$)!
- *Heyszl, Merli, Heinz, De Santis, Sigl, 'Strengths and limitations of high-resolution electromagnetic field measurements for side-channel analysis', CARDIS 2012

Symmetric Crypto | Dual-Rail Countermeasure



High-Resolution EM vs. Dual Rail Precharge Logic

CHES 2017*



- Latest DRP logic (FPGA) on Xilinx Spartan 6 (45 nm) (placement controlled, routing aut.)
- Power analysis: Security gain 425. Helpful. Similar with 3 mm probe
- High-resolution EM: Security gain only 1.34 → Not helpful
- *Immler, Specht, Unterstein, 'Your Rails Cannot Hide from Localized EM: How Dual-Rail Logic Fails on FPGAs', CHES 2017

Symmetric Crypto | Leakage Resilience



Leakage-Resilience

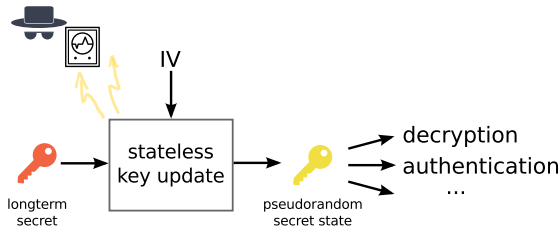
Re-Keying

- Goal is to prevent DPA (!)
- Alternative approach to more conventional masking or hiding
- Change key in every block-cipher execution
 - Even if attacker gets some leakage on one key, useless for next cipher execution
 - Prevent accumulating traces for DPA!
 - Change key by 'mixing' it completely (e.g. update through block cipher)
- Algorithmic level countermeasures - depends on application / protocol:
 - Live authentication: Fresh random numbers (on both sides) can be chosen to generate new session key (e.g. CIPURSE)
 - If both sides synchronized, updated key can be overwritten synchronously (stateful)
 - But we are interested in stateless case!

Leakage-Resilience

Re-Keying

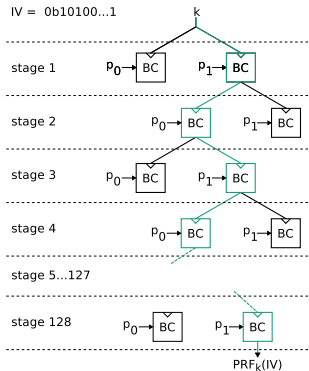
- FPGA receiving encrypted bitstreams:
 - We are looking into this application since years!
 - Must be decrypted from same longterm key always!
 - Bitstream cannot change (no fresh random numbers, no storing updated keys)
 - Attacker may even restart decryption to average noise!
 - How to have a longterm key and change it?



- Standaert et al. 2009, Medwed et al. CHES 2012:
Leakage-resilient Pseudo-Random Functions (PRFs)
- (Other proposal: Sponge-based 'ISAP' from TU GRAZ Debraunig et al. FSE 2017)

Leakage-Resilience Pseudo-Random Function

- Medwed et al. CHES 2012 based on GGM (Goldreich, Goldwasser, Micali) tree

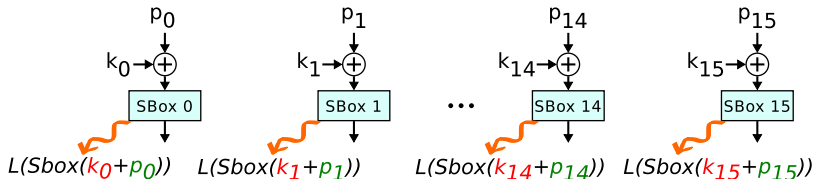


- This is how to get from longterm key k to updated key $\text{PRF}_k(\text{IV})$ using an IV
- Attacker even allowed to make device repeat this (e.g. average-out noise)
- But: In every layer, only two different inputs p_0 or p_1
- Very interesting about this: No random numbers required! No masking with all its pitfalls!

Leakage-Resilience

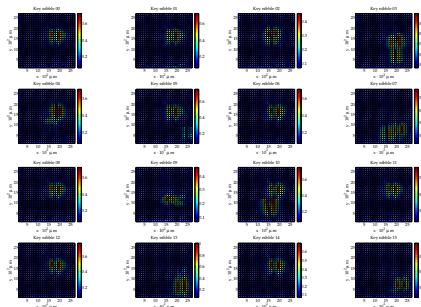
Two Main Concepts in Medwed/Standaert Direction

- Additionally, **algorithmic noise** from parallel S-Boxes which cannot be averaged-out
- No divide-and-conquer if input to all s-boxes equal (carefully chosen inputs)



■ Summary of Medwed/Standaert et al. direction:

1. Algorithmic noise through parallel s-boxes
(correlated because equal inputs; no averaging this out)
2. Limited data complexity (number of different traces for DPA)



- Evaluation of PRF construction parameters:
32 parallel PRESENT s-boxes. 2^4 data-complexity
- High-precision EM measurements, univariate profiled CPA
- S-boxes partly distinguished, reduced to $> 2^{80}$ after attack. OK, but threatening
- *Belaïd, De Santis, Heyszl, Mangard, Medwed, Schmidt, Standaert, Tillich, 'Towards fresh re-keying with leakage-resilient PRFs: cipher design principles and analysis', JCE 2014

Leakage-Resilience

- Based on this, we wanted to make it work ... But unsuccessful (see COSADE 2017 later)
- Then, Medwed et al. ASIACRYPT 2016:
 - Use *unknown inputs* p_x instead of p_0 and p_1 in GGM tree PRF
 - Improves security of tree: Inputs unknown, DPA impossible
 - AES-based, so **16** s-boxes, data-complexities > 2 in tree for increased performance
 - But *unknown inputs* must be derived somehow
 - Medwed et al. use PRG with (1) parallelism noise and (2) input limit **2** again ...
- They target ASICs, where s-boxes are closely packed (should work better)
- We looked into it again on FPGAs ...

Leakage-Resilience

COSADE 2017*

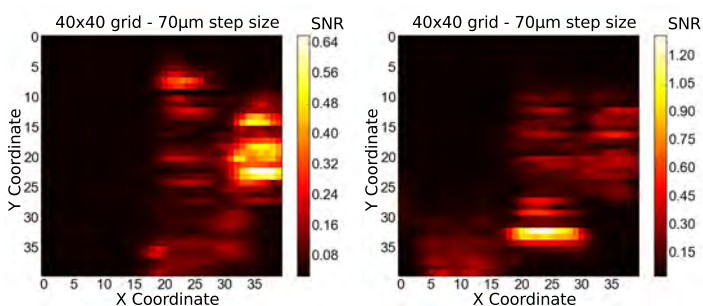
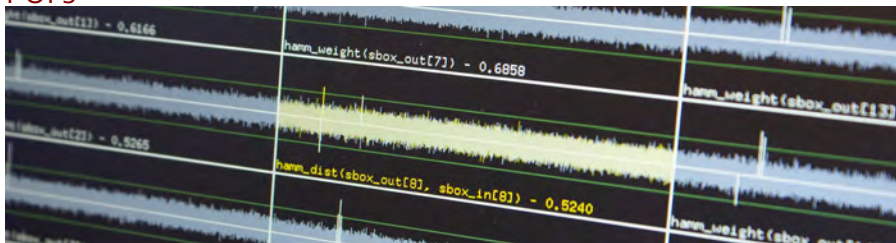


Figure: S-box 0 left, S-box 1 right

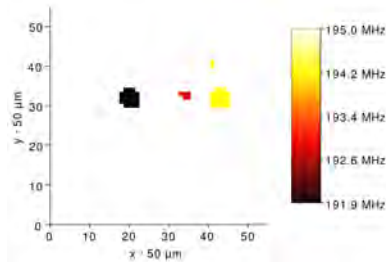
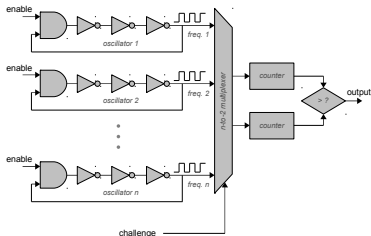
- New evaluation of PRF construction: 16 parallel AES s-boxes, minimal data complexity 2
- Multivariate profiled CPA incl. LDA: High SNRs of s-boxes on Xilinx Spartan-6 45 nm
- Reduces entropy to 2^{48} - not enough → Working on fixing currently (under review)
- *Unterstein, Heyszl, De Santis, Specht, 'Dissecting Leakage Resilient PRFs with Multivariate Localized EM Attacks', COSADE 2017

PUFs



Attacking RO-PUFs

HOST 2013*

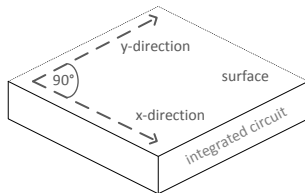


- Every RO assigned to one counter for comparison
- Attacker measures *RO frequency and sequence / counter assignment*
- Full characterization means full break
- *Merli, Heyszl, Heinz, Schuster, Stumpf, Sigl, 'Localized electromagnetic analysis of RO PUFs', HOST 2013

High resolution in the real world



Real World / Attacker's Perspective



- High-precision leads to higher SNR, but at which measurement position?
- Finding position is very difficult under real-world circumstances!
 - Looking for high signal strengths only helpful when exact time of execution known
 - (SNR computation or correlation-based leakage tests require many, aligned traces)
- But also time-alignment of traces w/o trigger difficult!
 - All discussed results used perfect alignment from trigger and synchronized scope
 - E.g. align on significant peaks and hope that attacked part is near to such a peak
 - Different coils lead to different 'looking' signals (e.g. different alignment peaks)
- Combination of misalignment and unknown positions is very demanding in practice!

Prediction and Modelling?

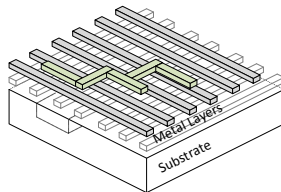
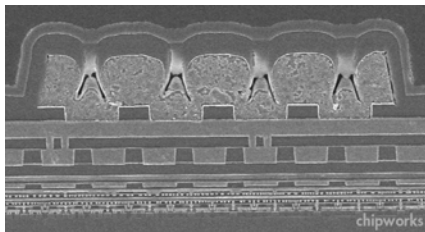


Figure: Left: Chipworks, TSMC 28 nm, Xilinx Kintex-7

- Is there a reasonable way of predicting leakage from high-precision EM (or position)?
- Data-dependent currents through different layers. Very DUT and technology-specific!
- Even after fully completed backend design (P&R etc.) difficult to predict exactly (opinion)
- Electric modelling in SPICE seems infeasible: Slow even for few transistors, but digital designs have e.g. $10^3 - 10^6$...
- Open question

Protection?

- Real-world:
 - For many e.g. IoT devices, chip decapsulation is not realistic
 - Conventional countermeasures such as time-based hiding increase difficulty massively
 - Prevent trace patterns that can be used for alignment
 - Dedicated to location-based leakage (e.g. ECC): location-randomization

- Research-world:
 - We still work on leakage resilience :)
 - EM sensor to detect equipment (Homma et al. CHES 2014)

Conclusion

- High-precision EM is very powerful, especially against FPGAs
- Not always 'easy' to perform, requires expensive setup and automation
- Currently, high-precision EM measurements seem required to assess security level

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